

Notice of References Cited

Application/Control No.

10/593,864

Applicant(s)/Patent Under
Reexamination
MAEDE ET AL.

Examiner

Gene W. Lee

Art Unit

2629

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,961,009 A	10-1990	Baik, Woo H.	327/103
*	B	US-6,317,138 B1	11-2001	Yano et al.	345/589
*	C	US-2003/0052904 A1	03-2003	Gu, Gong	345/691
*	D	US-2004/0174388 A1	09-2004	Sempel et al.	345/691
*	E	US-2005/0184933 A1	08-2005	Tomohara, Kiyohide	345/076
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.